Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	("6596562").PN.	US-PGPUB; USPAT	OR	OFF	2005/05/31 12:32
L3	9512	(dicing or sigulating) with (die or wafer or substrate)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:00
L4	4357	3 and pressure	US-PGPUB; USPAT	OR	ON	2005/05/31 12:33
L5	1132	4 and grooves	US-PGPUB; USPAT	OR	ON	2005/05/31 12:34
L6	269	5 and ((apply or applying) with pressure)	US-PGPUB; USPAT	OR	ON	2005/05/31 13:30
L7	242	6 and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 13:31
L8	46	grooves and (substrate or dice or wafer) and diaphram and pressure and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 13:10
L9	19	(singulating with dice) and grooves and (substrate or dice or wafer) and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 13:13
L10	177	(singulating with dice) and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 13:09
L11	158	10 not 9	US-PGPUB; USPAT	OR	ON	2005/05/31 12:52
L12	158	11 not 7	US-PGPUB; USPAT	OR	ON	2005/05/31 12:52
L13	577	(cutting with dice) and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 13:09
L14	103	13 and grooves	US-PGPUB; USPAT	OR	ON	2005/05/31 13:10
L15	96	14 not 9	US-PGPUB; USPAT	OR	ON	2005/05/31 13:10
L16	94	15 not 7	US-PGPUB; USPAT	OR	ON	2005/05/31 13:10
L17	94	16 not 12 .	US-PGPUB; USPAT	OR	ON	2005/05/31 13:10
L18	3	(singulating with dice) and grooves and (substrate or dice or wafer) and (bend or bow) and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 13:14
L19	73	(singulating with (substrate or wafer)) and (bend or bow) and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 13:15
L20	899	3 and ((apply or applying) with pressure)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:01

L21	793	20 and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 14:01
L22	551	21 not 7	US-PGPUB; USPAT	OR	ON	2005/05/31 13:32
L24	267	22 and (flexible or elastic)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:01
L25	284	22 not 24	US-PGPUB; USPAT	OR	ON	2005/05/31 13:47
L26	10238	(dicing or singulating) with (die or wafer or substrate)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:30
L27	969	26 and ((apply or applying) with pressure)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:22
L28	856	27 and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 14:22
L29	305	28 not 22	US-PGPUB; USPAT	OR	ON	2005/05/31 14:01
L30	198	29 and (flexible or elastic)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:09
L31	107	29 not 30	US-PGPUB; USPAT	OR	ON	2005/05/31 14:09
L32	872	(dicing or singulating) with (dice)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:24
L33	94	32 and ((apply or applying) with pressure)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:25
L34	81	33 and @ad<"20031027"	US-PGPUB; USPAT	OR ·	ON	2005/05/31 14:25
L35	621	(cutting) with (dice)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:27
L36	49	35 and ((apply or applying) with pressure)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:31
L37	45	36 and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 14:27
L38	22506	(cutting) with (die)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:27
L39	3099	38 and ((apply or applying) with pressure)	US-PGPUB; USPAT	OR	ON	2005/05/31 15:09
L40	2949	39 and @ad<"20031027"	US-PGPUB; USPAT	OR	ON	2005/05/31 14:52
L41	527	40 and (flexibale or bow or elastic)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:33
L42	527	41 not 25	US-PGPUB; USPAT	OR	ON	2005/05/31 14:29
L43	5889	(dicing or singulating) with (die or dice or wafer or substrate)	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/31 14:33

L44	37	43 and ((apply or applying) with pressure)	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/31 14:33
L45	38338	(cutting) with (die or dice or wafer or substrate)	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/31 14:33
L46	1517	45 and ((apply or applying) with pressure)	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/31 14:33
L47	129	46 and (flexibale or bow or elastic)	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/31 14:33
L48	1819	dicing and substrate and (flexible) and pressure	US-PGPUB; USPAT	OR	ON	2005/05/31 15:01
L49	1253	48 and applying	US-PGPUB; USPAT	OR	ON	2005/05/31 14:53
L50	444	48 and (applying with pressure)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:53
L51	144	50 and (bend or bow)	US-PGPUB; USPAT	OR	ON	2005/05/31 14:53
L52	19	dicing and substrate and (flexible) and pressure	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/31 15:01
L54	0	(oi adj fong adj chin) or (yew adj wee adj cheong) or (weng adj khoon adj mong)	US-PGPUB; USPAT	OR	ON	2005/05/31 15:12
L56	0	(oi adj fong adj chin) or (yew adj wee adj cheong) or (weng adj khoon adj mong)	USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/05/31 15:12

DERWENT-ACC-NO:

2000-372436

DERWENT-WEEK:

200032

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TITLE:

<u>Wafer dicing</u> for use during semiconductor integrated circuit manufacture, involves adjoining spacer to cleavage plane of <u>wafer and applying pressure</u> simultaneously to <u>wafer</u> and spacer so that <u>wafer</u> breaks to pieces

----- KWIC -----

Basic Abstract Text - ABTX (2):

USE - For <u>dicing</u> semiconductor <u>wafer</u> that mounts semiconductor chip e.g. LED chip for semiconductor integrated circuit manufacture.

Title - TIX (1):

<u>Wafer dicing</u> for use during semiconductor integrated circuit manufacture, involves adjoining spacer to cleavage plane of <u>wafer and applying pressure</u> simultaneously to <u>wafer</u> and spacer so that <u>wafer</u> breaks to pieces

Standard Title Terms - TTX (1):

WAFER DICE SEMICONDUCTOR INTEGRATE CIRCUIT MANUFACTURE ADJOIN SPACE CLEAVE PLANE WAFER APPLY PRESSURE SIMULTANEOUS WAFER SPACE SO WAFER BREAK PIECE

DERWENT-ACC-NO:

2004-812350

**DERWENT-WEEK:** 

200517

## COPYRIGHT 2005 DERWENT INFORMATION LTD

TITLE:

<u>Cutting</u> of glass sheet or PDP <u>substrate</u> comprises forming linear groove in glass sheet along programmed <u>cutting</u> line that is set for glass sheet, and <u>applying</u> local <u>pressure</u> to end of groove

I	KWIC	-
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Basic Abstract Text - ABTX (1):

NOVELTY - Glass sheet is cut by forming a linear groove in glass sheet along a programmed cutting line that is set for the glass sheet, and <u>applying</u> local <u>pressure</u> to an end of the groove.

Basic Abstract Text - ABTX (4):

(B) a cutting apparatus for cutting a glass sheet comprising <u>elastic</u> plate arranged at an end of a programmed cutting line of a glass sheet for dissipating <u>pressure</u>, <u>pressure</u> absorber arranged on the rear surface of the glass sheet opposing the end of the cutting line, and pressurizing mechanism (6) for <u>applying pressure to the elastic</u> plate.

Basic Abstract Text - ABTX (5):

USE - For <u>cutting</u> a glass sheet or PDP <u>substrate</u>.

Basic Abstract Text - ABTX (7):

DESCRIPTION OF DRAWING(S) - The figure is front view showing another part of the **cutting** apparatus for **cutting** a PDP **substrate**.

Basic Abstract Text - ABTX (16): Elastic plates 15, 20

Title - TIX (1):

<u>Cutting</u> of glass sheet or PDP <u>substrate</u> comprises forming linear groove in glass sheet along programmed <u>cutting</u> line that is set for glass sheet, and <u>applying</u> local <u>pressure</u> to end of groove

Standard Title Terms - TTX (1): CUT GLASS SHEET SUBSTRATE COMPRISE FORMING LINEAR GROOVE **GLASS SHEET** 

PROGRAM CUT LINE SET GLASS SHEET APPLY LOCAL PRESSURE END **GROOVE** 

5/31/05, EAST Version: 2.0.1.4